

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/723,874	OHBA, AKIO	
Examiner	Art Unit	
Sheela C. Chawan	2624	

	SEARCHED				
Class	Subclass	Date	Examiner		
382	103, 144,	8/4/2006	scc		
382	117,118	8/4/2006	scc		
382	162,165	8/4/2006	scc		
382	173,181	8/4/2006	scc		
382	190,199	8/4/2006	scc		
382	240,284	8/4/2006	scc		
382	260,294	8/4/2006	scc		
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382	214	8/4/2006	scc		
348	14.16,169	8/4/2006	scc		
348	588,36	8/4/2006	scc		
348	87,	8/4/2006	scc		
345	428,31,	8/4/2006	scc		
345	592,630	8/4/2006	scc		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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	DATE	EXMR
EAST, US- PGPUB,USPAT,EPO,JPO,DERWENT ,IBM-TDB	8/4/2006	scc
INVENTOR NAME SEARCH.	8/4/2006	scc